

Notice of References Cited

Application/Control No.

10/015,086

Applicant(s)/Patent Under
Reexamination
BERNSTEIN ET AL.

Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0049193	12-2001	Golecki et al.	438/674
	B	US-6,476,333	11-2002	Khandros et al.	174/267
	C	US-2003/0099097	05-2003	Mok et al.	361/767
	D	US-6,663,035	12-2003	Shiga et al.	242/348.2
	E	US-6,624,003	09-2003	Rice, Janet L.	438/106
	F	US-6,102,531	08-2000	Gentsu, Takuya	347/72
	G	US-2003/0216700	11-2003	Pearson et al.	604/266
	H	US-6,236,139	05-2001	Hill et al.	310/307
	I	US-6,307,452	10-2001	Sun, Xi-Qing	333/262
	J	US-2001/0008157	07-2001	Bishop et al.	148/678
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05174932 A	07-1993	Japan	SAYAMA, MITSUYOSHI	H01R 39/20
	O	FR 2458151 A	01-1981	France	DUCHET, C	H01L 41/08
	P	JP 11-284244	10-1999	Japan	GENDOSHI TAKUYA	H01L 41/09
	Q	JP 2001-337110	12-2001	Japan	TAKA KAORU	G01R 31/26
	R	DE 19809961 A1	09-1999	Germany	GEHLERT et al.	C22C 05/02
	S	JP 57-057421 A	04-1982	Japan	TOKURIKI HONTEN KK	C22C 005/04
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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